

Search Notes

Application/Control No.

10/022,536

Examiner

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Applicant(s)/Patent under
Reexamination

OHASHI, TADASHI

Art Unit

2166

SEARCHED

Class	Subclass	Date	Examiner
707	100-104.1	2/28/2007	IW
715	500-529	2/28/2007	IW

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PGPUB&USPAT text search - See history search printout		2/28/2007	IW

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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